Atty. Docket No.: 034299-626

In the Claims

The following Listing of Claims replaces all prior versions in the application:

LISTING OF CLAIMS

- 1. (Currently Amended) A method for manufacturing at least one electrode on a II-VI semiconducting material or a compound of this material the II-VI semiconductor material, this electrode the at least one electrode being in a metal for which the work function is substantially equal to or larger than that of the II-VI semiconductor the II-VI semiconducting material, this method being characterized in that the electrode the at least one electrode is formed by electrochemical deposition of the metal from a solution of a chloride of the metal in a hydrochloric acid solution, wherein the hydrochloric acid solution consists essentially of pure hydrochloric acid diluted by less than about 80% water by weight.
- 2. (Currently Amended) The method according to claim 1, wherein the metal is gold or platinum and a gold or platinum chloride solution in pure hydrochloric acid a gold chloride solution or a platinum chloride solution in pure hydrochloric acid is used.
- 3. (Currently Amended) The method according to claim 2, wherein the concentration of gold or platinum chloride a concentration of gold chloride or platinum chloride in pure hydrochloric acid is less than 5%.
- 4. (Currently Amended) The method according to claim 1, wherein the surface of the material a surface of the material is prepared before the deposition in order to make this surface capable of fixing the metal.

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- 5. (Original) The method according to claim 4, wherein the surface of the material is chemically etched.
- 6. (Currently Amended) The method according to claim 5, wherein the metal is gold or platinum, a gold or platinum chloride solution in pure hydrochloric acid is used and a solution of bromine and preferably pure hydrochloric acid hydrochloric acid is used for the chemical etching.
- 7. (Currently Amended) The method according to claim 1, wherein the material the II-VI semiconducting material is CdTe.
- 8. (Currently Amended) The method according to claim 7, wherein the electrode the at least one electrode is formed on a material a compound of CdTe which is selected from CdZnTe, CdTe:Cl, CdTeSe:Cl, CdZnTe:Cl, CdZnTe:In and CdHgTe.
- 9. (New) The method according to claim 6, wherein a solution of bromine and pure hydrochloric acid is used for the chemical etching.
- 10. (New) The method according to claim 1, wherein the hydrochloric acid solution consists essentially of pure hydrochloric acid.